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**Information technology —  
Telecommunications and information  
exchange between systems — Near Field  
Communication Interface and Protocol  
(NFCIP-1) — RF interface test methods**

*Technologies de l'information — Télécommunications et échange  
d'information entre systèmes — Interface et protocole de  
communication en champ proche (NFCIP-1) — Méthodes d'essai pour  
interface RF*

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